Search Notes



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Examiner

Art Unit 2617

Nguyen, Huy D

SEARCHED

Class	Class Subclass		Examiner
455	411, 410, 445, 432.1, 432.2, 433, 552.1, 553.1, 426.1, 435.1, 435.2,	2/6/2008	HN
370	466, 467	2/6/2008	HN
713	168, 171, 172, 176	2/6/2008	HN
380	258	2/6/2008	HN
Updated search	same as above	8/13/2008	HN

SEARCH NOTES

Search Notes	Date	Examiner
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT).See	02/06/2008	HN
search history printout.		
East; Text search (USPAT, US-PGPUB, JPO, EPO, DERWENT).See	8/13/2008	HN
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See interference search history.	8/13/2008	HN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
455	411, 410, 445, 432.1	8/13/2008	HN
370	466, 467	8/13/2008	HN
713	168, 171, 172, 176	8/13/2008	HN
380	258	8/13/2008	HN

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